















**ESD** 

TVS

MOS

LDO

Diode

Sensor

DC-DC

# **Product Specification**

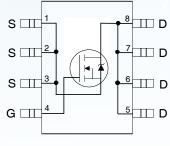
Domestic Part Number	IRF7403
<ul><li>Overseas Part Number</li></ul>	IRF7403
▶ Equivalent Part Number	IRF7403





#### **Features**

- Generation VTechology
- Ultra Low On-Resistance N-ChannelMosfet
- Surface Mount
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free



Top View

### **Description**

The SOP-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase. infra red. or wave so derina techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>A</sub> = 25°C	10 Sec. Pulsed Drain Current, V <sub>GS</sub> @ 10V	9.7	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	8.5	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	5.4	A
I <sub>DM</sub>	Pulsed Drain Current ①	34	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/°C
$V_{GS}$	Gate-to-Source Voltage	±20	V
dv/dt	Peak Diode Recovery dv/dt ②	5.0	V/ns
$T_{J,}T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	°C

#### **Thermal Resistance Ratings**

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient⊕		50	°C/W



## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

		`				<u> </u>
	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.024		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
В	Static Drain-to-Source On-Resistance			0.022	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.0A ③
R <sub>DS(ON)</sub>	Static Dialii-to-Source Oil-Resistance			0.035	22	$V_{GS} = 4.5V, I_D = 3.4A$ ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$
g <sub>fs</sub>	Forward Transconductance	8.4			S	$V_{DS} = 15V, I_{D} = 4.0A$
	Drain to Course Leakage Current			1.0	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			25	μΑ	$V_{DS} = 24V$ , $V_{GS} = 0V$ , $T_{J} = 125$ °C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
IGSS	Gate-to-Source Reverse Leakage			-100	IIA	V <sub>GS</sub> = -20V
Qg	Total Gate Charge			57		I <sub>D</sub> = 4.0A
$Q_{gs}$	Gate-to-Source Charge			6.8	nC	V <sub>DS</sub> = 24V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			18		$V_{GS}$ = 10V, See Fig. 6 and 12 ③
t <sub>d(on)</sub>	Turn-On Delay Time		10			V <sub>DD</sub> = 15V
t <sub>r</sub>	Rise Time		37		no	$I_D = 4.0A$
t <sub>d(off)</sub>	Turn-Off Delay Time		42		ns	$R_G = 6.0\Omega$
t <sub>f</sub>	Fall Time		40			$R_D$ = 3.7 $\Omega$ , See Fig. 10 ③
L <sub>D</sub>	Internal Drain Inductance		2.5		nH	Between lead tip
L <sub>S</sub>	Internal Source Inductance	_	4.0			and center of die contact
C <sub>iss</sub>	Input Capacitance		1200			V <sub>GS</sub> = 0V
Coss	Output Capacitance		450		pF	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		160			f = 1.0MHz, See Fig. 5

### Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			3.1		MOSFET symbol
İ	(Body Diode)			3.1	Α	showing the
I <sub>SM</sub>	Pulsed Source Current			24		integral reverse
İ	(Body Diode) ①			34	34	p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.0	V	$T_J = 25^{\circ}C$ , $I_S = 2.0A$ , $V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		52	78	ns	$T_J = 25$ °C, $I_F = 4.0$ A
Q <sub>rr</sub>	Reverse RecoveryCharge		93	140	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intri	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- $\begin{tabular}{ll} @ & I_{SD} \leq 4.0A, \; di/dt \leq 180A/\mu s, \; V_{DD} \leq V_{(BR)DSS}, \\ & T_{J} \leq 150 ^{\circ} C \end{tabular}$
- $\ \, \mbox{\Large \textcircled{4}} \mbox{ Surface mounted on FR-4 board, } \mbox{ } t \leq \mbox{ 10sec.}$



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

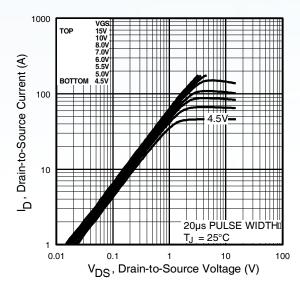


Fig 1. Typical Output Characteristics

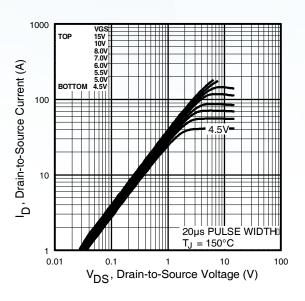


Fig 2. Typical Output Characteristics

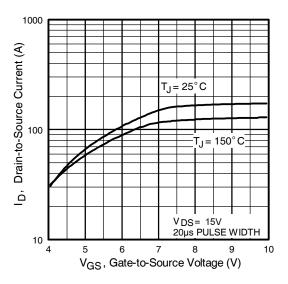
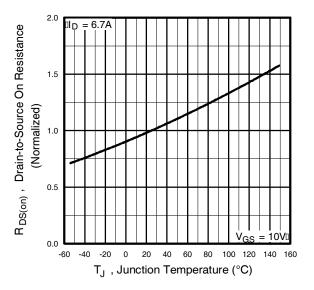


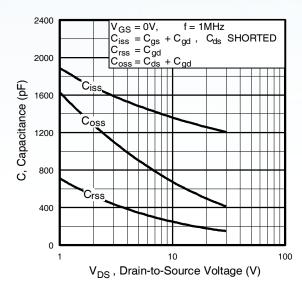
Fig 3. Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

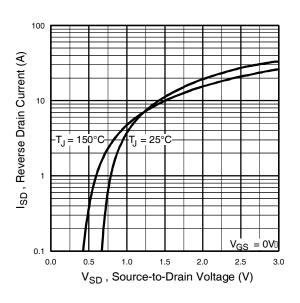
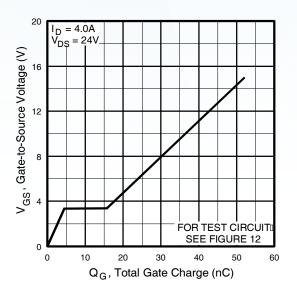


Fig 7. Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

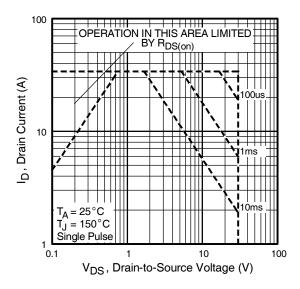


Fig 8. Maximum Safe Operating Area



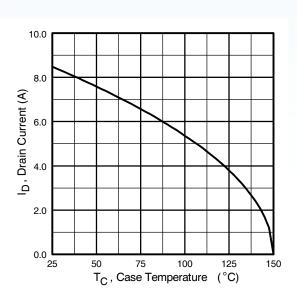


Fig 9. Maximum Drain Current Vs.
Ambient Temperature

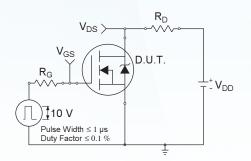


Fig 10a. Switching Time Test Circuit

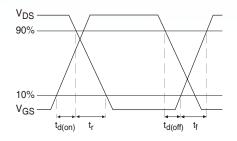


Fig 10b. Switching Time Waveforms

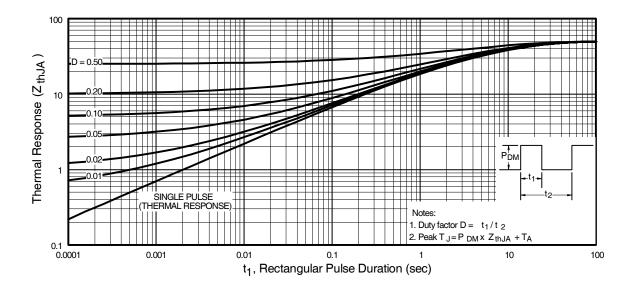


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



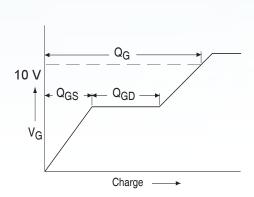


Fig 12a. Basic Gate Charge Waveform

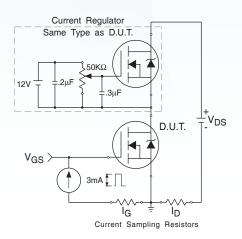
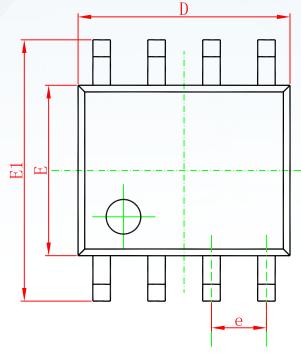
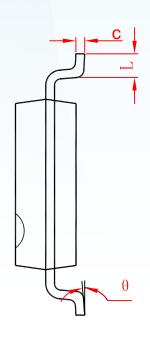


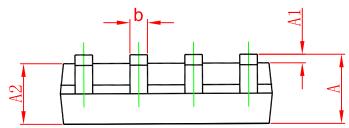
Fig 12b. Gate Charge Test Circuit



SOP-8



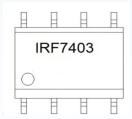




Cymhal	Dimensions In	Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
Е	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270	(BSC)	0.050	O(BSC)	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



# Marking



# **Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF7403	SOP-8	3000	Tape and reel



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